


<b>Search Notes</b> 	<b>Application/Control No.</b> 10534585	<b>Applicant(s)/Patent Under Reexamination</b> AHN ET AL.
	<b>Examiner</b> Xiuyu Tai	<b>Art Unit</b> 1795

SEARCHED			
Class	Subclass	Date	Examiner
422	186.01	6/3/2008	xt

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search, assignee search, US-PGPUB, USPAT, USOCR, EPO, JPO, FPRS, DERWENT, GOOGLE	6/2/2008	xt

INTERFERENCE SEARCH			
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